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Application No. 14/4/55/2	Prepared by	Tracking Number 5074753
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Application Number	09/945512
Filing Date	August 30, 2001
First Named Inventor	Forbes, Leonard
Group Art Unit	2812
Examiner Name	Booth, Richard

Attorney Docket No: 1303.027US1

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Application Number	09/945,512
Filing Date	August 30, 2001
First Named Inventor	Forbes, Leonard
Group Art Unit	2812
Examiner Name	Booth, Richard

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